

Influences of synthesizing temperatures on the properties of $\text{Cu}_2\text{ZnSnS}_4$ prepared by sol–gel spin-coated deposition

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Received: 23 January 2009 / Accepted: 14 May 2009 / Published online: 29 May 2009
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Abstract In this work $\text{Cu}_2\text{ZnSnS}_4$ (CZTS) suitable for the absorption layer in solar cells was successfully prepared by sol–gel spin-coated deposition. CZTS precursors were prepared by using solutions of copper (II) chloride, zinc (II) chloride, tin (IV) chloride, and thiourea. Texture structures with kesterite crystallinity reflected from the X-ray diffraction of (112), (200), and (312) planes of the CZTS were obtained as synthesized at a temperature of over 240 °C. The absorption coefficients of the CZTS films are higher than 10^4 cm^{-1} , and the optical-energy gap is about 1.5 eV. Without sulfurization treatment, a near stoichiometry composition of the CZTS is obtained at a synthesizing temperature of 280 °C.

Keywords $\text{Cu}_2\text{ZnSnS}_4$ · Absorption layer · Solar cells · Sol-gel spin-coated deposition

1 Introduction

CZTS is a kind of p-type direct band gap semiconductor with a band-gap value of ~ 1.5 eV. The crystal chemistry of CZTS with kesterite structure has been investigated in

recent works [1, 2]. It has the similar stannite structure of $\text{CuIn}_x\text{Ga}_{1-x}\text{Se}_2$ (CIGS) and like CIGS is one of the potential materials for solar cells. However, as compared to CIGS, it is of low cost, non-toxic and abundant with a large absorption coefficient in the order of 10^4 cm^{-1} [3–5], which make it a suitable absorption layer for applications in thin film solar cells. There are many kinds of methods to prepare CZTS such as spray pyrolysis deposition [6, 7], electron-beam-evaporation [4, 8, 9], rf magnetron sputtering deposition [5, 10], and sol–gel deposition [11]. In this work, the characterization of the CZTS prepared by using sol–gel spin-coated deposition is presented.

2 Experimental methods

In this work, soda lime glass (SLG) is used as substrates. The SLG substrates were cleaned in an ultrasonic acetone bath for 10 min, and then rinsed with deionized water. CZTS precursors were prepared by using the solutions of copper (II) chloride, zinc (II) chloride, tin (IV) chloride, and thiourea in a mixture of 2, 1, 1, and 8 mol/L, respectively and dissolved in deionized water containing 30 vol% ethanol. The solutions were stirred at 40 °C for 30 min and then spinning coated on the SLG substrate at a speed of 1,350 rpm. After the spin-coated deposition, the films were baked for drying on a hot plate at 110 °C for 10 min, and then synthesized, respectively at a different temperature in a range of 160–320 °C for 20 min. The spin-coated and synthesizing processes were repeated 3 times to obtain a suitable thickness of CZTS.

3 Results and discussion

The surface morphology and the cleavage of the CZTS were examined by scanning electron microscope (SEM).

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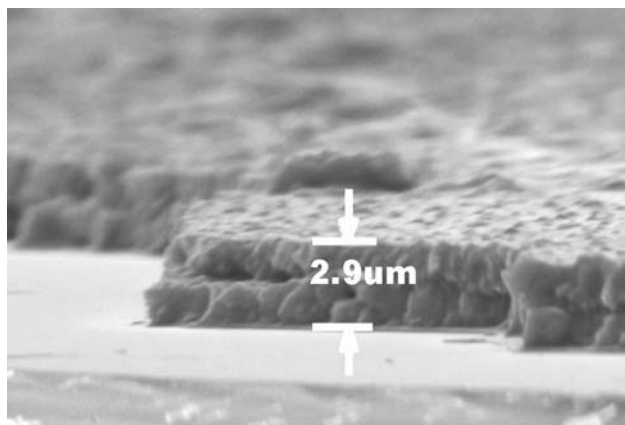


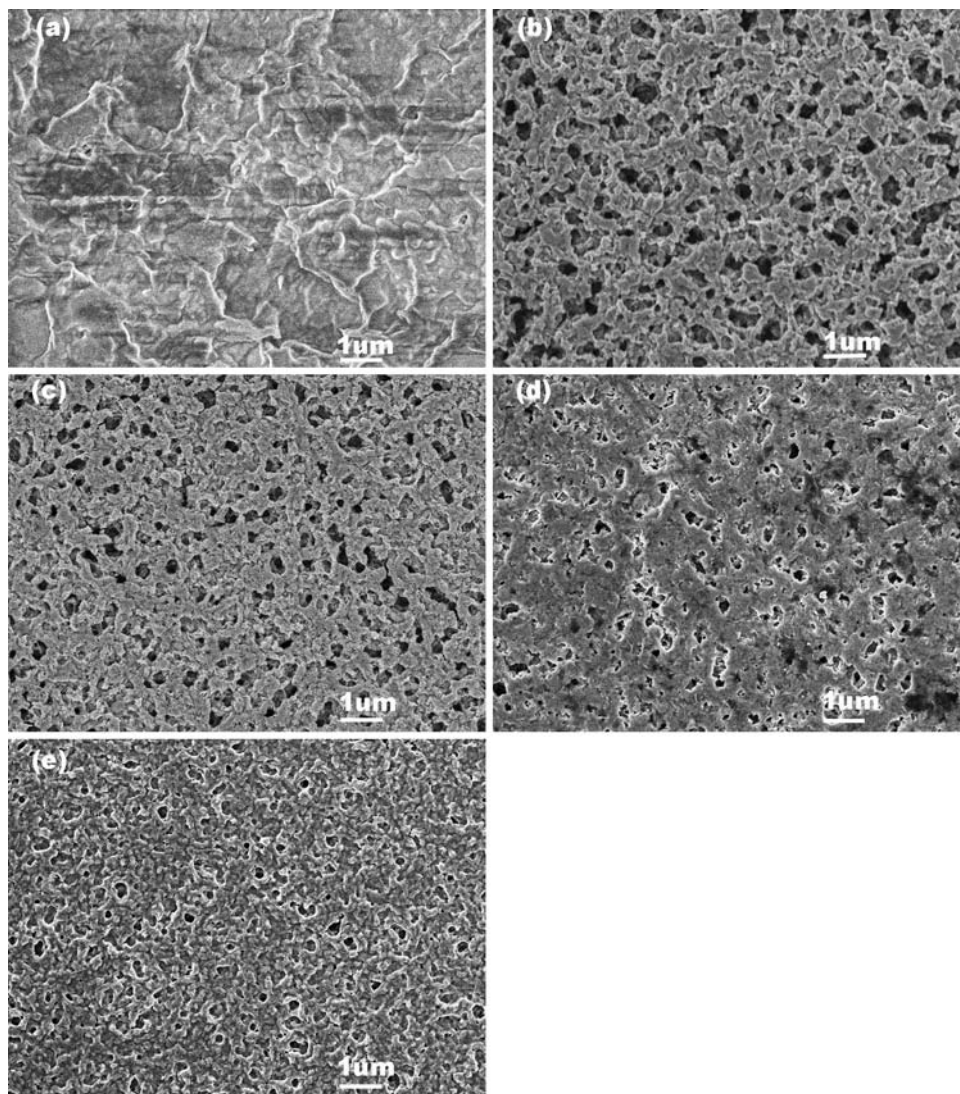
Fig. 1 Cleavage SEM image of the CZTS thin film

Figure 1 shows the cleavage image of the CZTS thin film with a thickness of 2.9 μm, which is obtained as synthesized at 160 °C. As we can see, that the CZTS layer is

continuous and uniform. Figure 2 shows the surface morphology of the CZTS synthesized at different temperatures. Texture structures of the CZTS films are formed at a synthesizing temperature of higher than 160 °C. The crystallinity of the CZTS was characterized by an X-ray diffractometer (XRD). From Fig. 3, we can see that the degree of crystallinity of the CZTS increases with synthesizing temperatures. Below 280 °C, the CZTS may not have a complete synthesization, and thus there appears an unidentified phase as shown by the peak locating at near 50°. The CZTS reflects the kesterite structure with the major XRD diffraction from (112), (200), (220) and (312) planes as the synthesizing temperature is higher than 240 °C. This means that in this work the suitable CZTS synthesizing temperature is no less than 280 °C.

The composition ratios of the deposited CZTS thin films were measured by energy dispersive spectroscopy. Figure 4 shows that the composition ratio of sulfur in the CZTS

Fig. 2 Surface morphology of CZTS films synthesized at (a) 160 (b) 200 (c) 240 (d) 280 (e) 320 °C



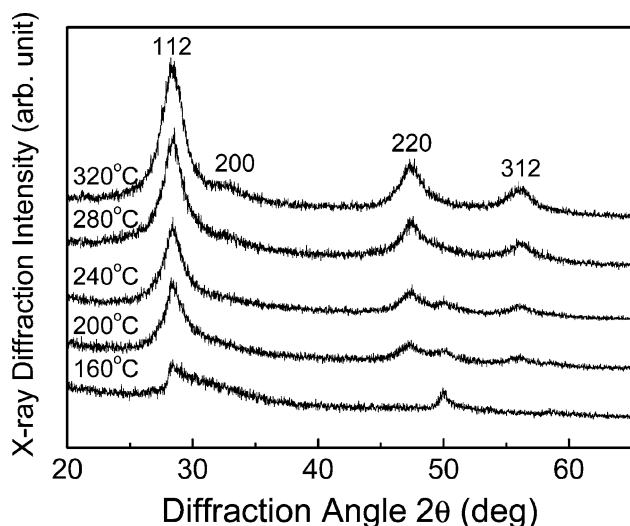


Fig. 3 XRD patterns of CZTS thin films as a function of synthesized temperatures

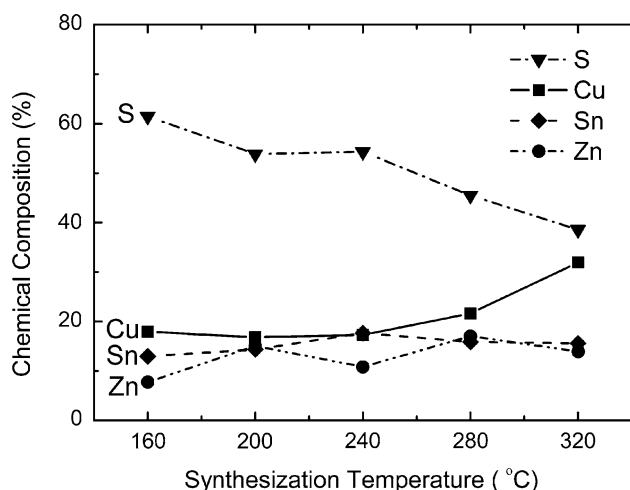


Fig. 4 Chemical composition of CZTS films as a function of synthesis temperatures

decreases obviously with synthesizing temperatures. The composition ratio of copper is less than 20% as synthesized at 160 °C, and then gradually rises with synthesizing temperatures to a value of close to 25% at 280 °C. Without sulfurization treatment, the CZTS film is found to have a near stoichiometry composition as prepared at a synthesizing temperature of 280 °C.

The transmittance and reflectance of the CZTS films were examined by a photo spectrometer. Figure 5 shows the optical absorption spectra of the CZTS obtained at different synthesized temperatures. The CZTS films have high optical absorption figures with respect to the photo energy of solar irradiation. As we can see, the CZTS films synthesized at a temperature of higher than 160 °C have high optical-absorption properties in a wider band of

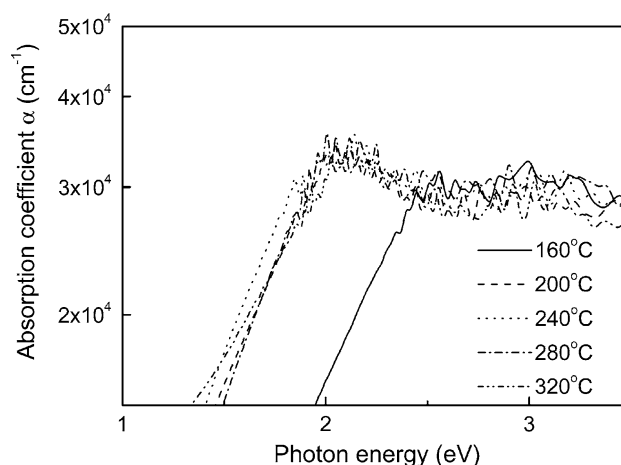


Fig. 5 Optical absorption spectra of the CZTS synthesized at different temperatures of 160–320 °C

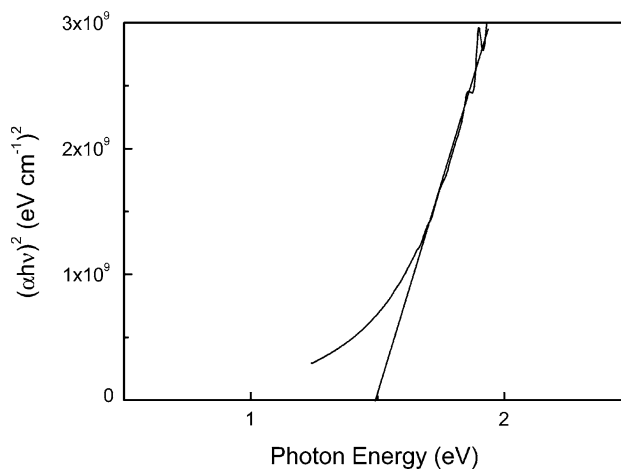


Fig. 6 Square absorption coefficients of the CZTS synthesized at 320 °C, as a function of photon energy

photon energy. As shown in Fig. 6, the optical-energy gap of the CZTS film is determined by extrapolating the linear part of the spectrum of the square absorption coefficients of the CZTS as a function of photon energy. The average optical-absorption coefficient was derived from the CZTS absorption coefficient with respect to the photo energy from 1.8 to 3.1 eV. As shown in Fig. 7, the average absorption coefficient of the CZTS is higher than 10^4 cm^{-1} , and the optical energy gap is about 1.5 eV except the sample prepared at 160 °C.

4 Conclusions

In this work, solutions of copper (II) chloride, zinc (II) chloride, tin (IV) chloride, and thiourea are used as the precursors for preparing CZTS thin films. CZTS thin films

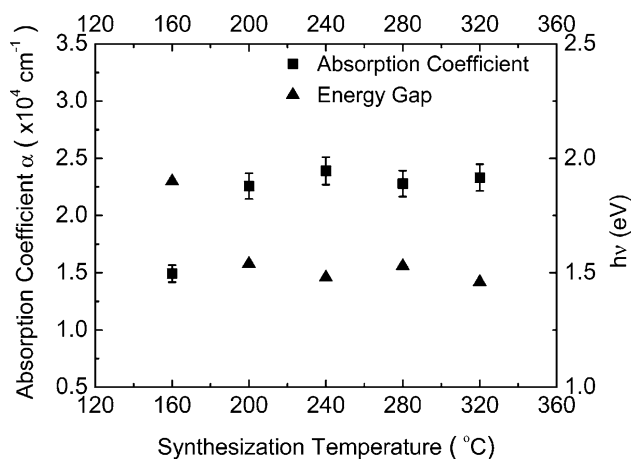


Fig. 7 Absorption coefficient and optical band gap of the CZTS films as a function of synthesis temperatures

are successfully prepared on SLG substrates by sol–gel spin-coated deposition. Texture structures of the CZTS films are obtained at a synthesizing temperature of higher than 160 °C. The kesterite structures of the CZTS films result from the synthesizing processes at a temperature of over 240 °C. The CZTS film with a near stoichiometry composition is prepared at a synthesizing temperature of 280 °C. The absorption coefficient and the optical energy gap of the CZTS films are $\sim 2 \times 10^4 \text{ cm}^{-1}$ and $\sim 1.5 \text{ eV}$, respectively.

Acknowledgment This work is supported by the National Science Council of the Republic of China under the contract No. NSC 97-2221-E-022-002.

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